

November 2013

FQD10N20L

N-Channel QFET® MOSFET

200 V, 7.6 A, 360 mΩ

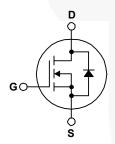
Description

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power • 100% Avalanche Tested factor correction (PFC), and electronic lamp ballasts.

Features

- 7.6 A, 200 V, $R_{DS(on)}$ = 360 m Ω (Max.) @ V_{GS} = 10 V, $I_D = 3.8 A$
- Low Gate Charge (Typ. 13 nC)
- Low Crss (Typ. 14 pF)
- · Low Level Gate Drive Requirements Allowing **Direct Operation Form Logic Drivers**





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter		FQD10N20LTM	Unit
V_{DSS}	Drain-Source Voltage		200	V
I _D	Drain Current - Continuous (T _C = 25°C)		7.6	Α
	- Continuous (T _C = 100°C)		4.8	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	30.4	Α
V _{GSS}	Gate-Source Voltage		± 20	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	180	mJ
I _{AR}	Avalanche Current	(Note 1)	7.6	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	5.1	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		5.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *		2.5	W
	Power Dissipation (T _C = 25°C)		51	W
	- Derate above 25°C		0.4	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	FQD10N20LTM	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.		
В	Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max.	110	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (*1 in ² Pad of 2-oz Copper), Max.	50	

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FQD10N20LTM	FQD10N20L	DPAK	Tape and Reel	330 mm	16 mm	2500 units

Electrical Characteristics

T_C = 25°C unless otherwise noted.

Symbol	Parameter	Parameter Test Conditions		Тур.	Max.	Uni
Off Cha	aracteristics					
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	200			V
ΔBV_{DSS} / ΔT_{J}	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.18		V/°C
I _{DSS}	Zoro Coto Voltogo Droin Current	V _{DS} = 200 V, V _{GS} = 0 V			1	μΑ
	Zero Gate Voltage Drain Current	V _{DS} = 160 V, T _C = 125°C			10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -20 V, V _{DS} = 0 V			-100	nA
	Aracteristics Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA	1.0		2.0	V
V _{GS(th)}	Static Drain-Source	V _{GS} = 10 V, I _D = 3.8 A	1.0	0.29	0.36	V Ω
	On-Resistance	$V_{GS} = 5 \text{ V}, I_D = 3.8 \text{ A}$		0.3	0.38	
g _{FS}	Forward Transconductance	$V_{DS} = 30 \text{ V}, I_{D} = 3.8 \text{ A}$		9.6		S
Dynam	ic Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$	\	640	830	pF
C _{oss}	Output Capacitance	f = 1.0 MHz		95	125	pF
C _{rss}	Reverse Transfer Capacitance			14	18	pF
Switchi	ing Characteristics	,	1		1	
t _{d(on)}	Turn-On Delay Time	V 100 V I 10 A		13	35	ns
t _r	Turn-On Rise Time	$V_{DD} = 100 \text{ V}, I_D = 10 \text{ A},$ $R_C = 25 \Omega$		150	310	ns

t _{d(on)}	Turn-On Delay Time	V _{DD} = 100 V, I _D = 10 A,			13	35	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$			150	310	ns
t _{d(off)}	Turn-Off Delay Time		(Note 4)		50	110	ns
t _f	Turn-Off Fall Time				95	200	ns
Q_g	Total Gate Charge	V _{DS} = 160 V, I _D = 10 A,			13	17	nC
Q_{gs}	Gate-Source Charge	$V_{GS} = 5 \text{ V}$ (Not	e 4)		2.4		nC
Q _{gd}	Gate-Drain Charge			/	6.1		nC

Drain-Source Diode Characteristics and Maximum Ratings

I _S	Maximum Continuous Drain-Source Diode Forward Current		 	7.6	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		 	30.4	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 7.6 \text{ A}$	 	1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 10 A,	 120		ns
Q _{rr}	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s$	 0.57	//	μС

- Notes: 1. Repetitive rating : pulse-width limited by maximum junction temperature. 2. L = 4.7 mH, I_{AS} = 7.6 A, V_{DD} = 50 V, R_G = 25 Ω , starting T_J = 25°C. 3. I_{SD} ≤ 10 A, di/dt ≤ 300 A/ μ s, V_{DD} ≤ BV $_{DSS}$, starting T_J = 25°C.

- 4. Essentially independent of operating temperature.

Typical Characteristics

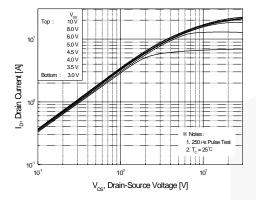


Figure 1. On-Region Characteristics

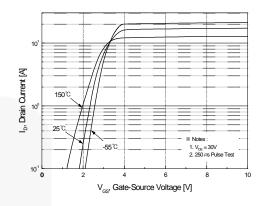


Figure 2. Transfer Characteristics

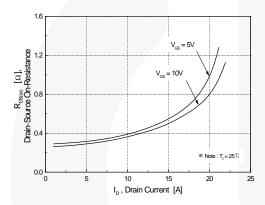


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

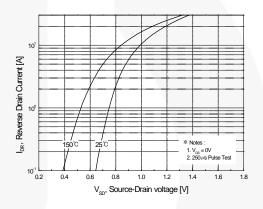


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

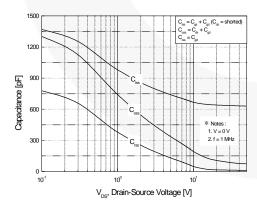


Figure 5. Capacitance Characteristics

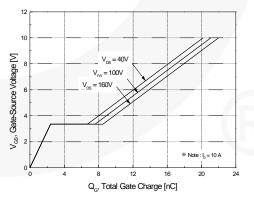


Figure 6. Gate Charge Characteristics

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Typical Characteristics (Continued)

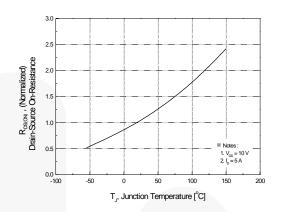
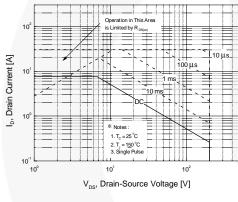


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



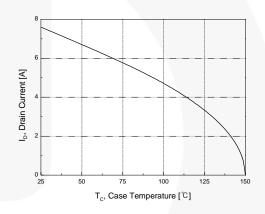


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

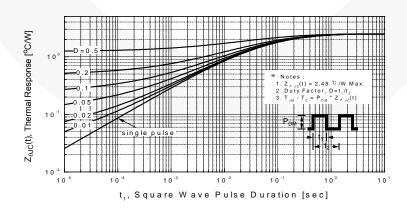


Figure 11. Transient Thermal Response Curve

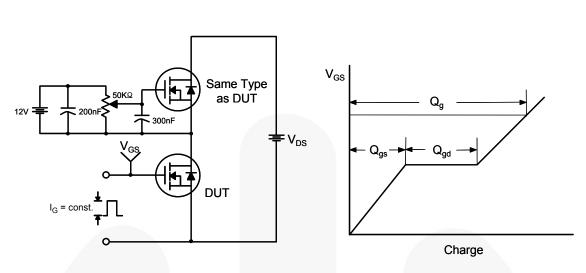


Figure 12. Gate Charge Test Circuit & Waveform

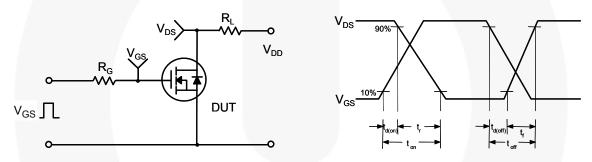


Figure 13. Resistive Switching Test Circuit & Waveforms

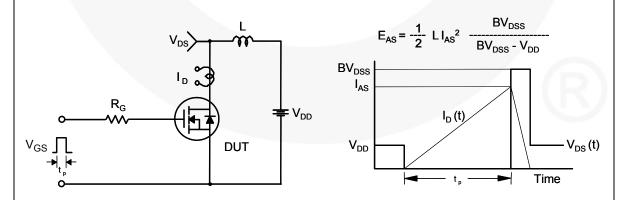
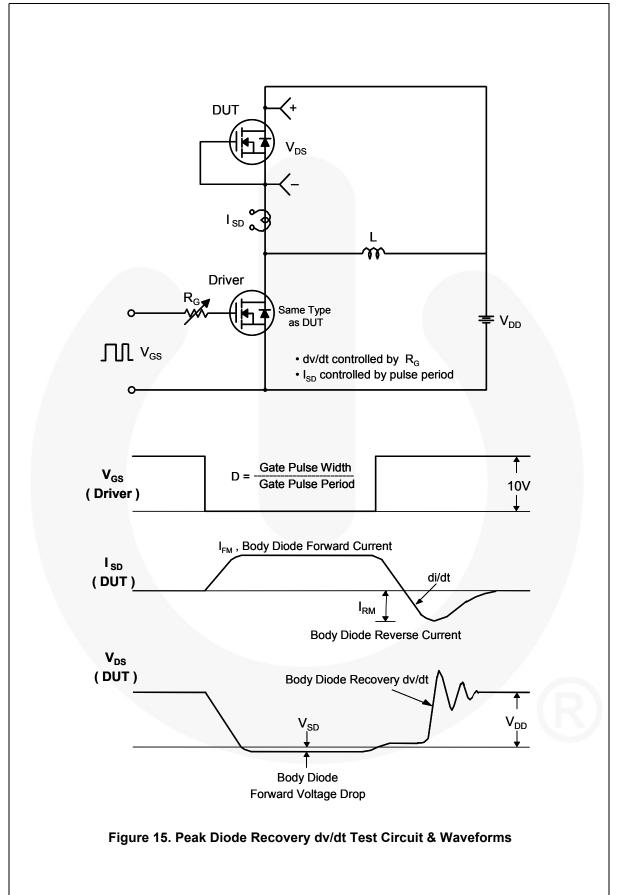
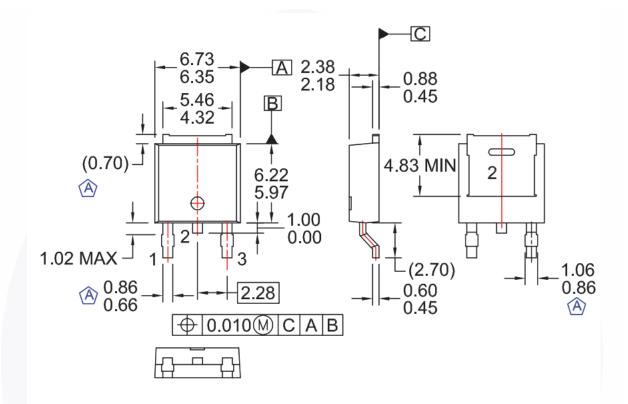


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



Mechanical Dimensions



NOTES: UNLESS OTHERWISE SPECIFIED

- (A) CONFORMS TO JEDEC TO-252 VARIATION AB EXCEPT WHERE NOTED
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DRAWING CONFORMS TO ASME Y14.5M-1994
- D) DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- E) FORMERLY NAMED BD1733
- F) DRAWING FILE NAME: MKT-TO252D03REV1

Figure 16. TO-252 (D-PAK), Molded, 3-Lead, Jedec TO-252 VAR. AB, Surface Mount

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